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Vishay/Siliconix SI5480DU-T1-E3

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Datasheet of SI5480DU-T1-E3 - MOSFET N-CH 30V 12A PPAK CHIPFET

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### **Si5480DU**

Vishay Siliconix

### N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)	
30	0.016 at V <sub>GS</sub> = 10 V	12	11 nC	
	0.022 at V <sub>GS</sub> = 4.5 V	12	11110	

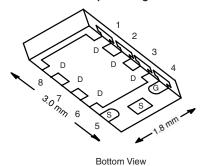
#### **FEATURES**

- Halogen-free
- TrenchFET<sup>®</sup> Power MOSFET
- New Thermally Enhanced PowerPAK<sup>®</sup> ChipFET<sup>®</sup> Package
  - Small Footprint Area
  - Low On-Resistance
  - Thin 0.8 mm Profile

# Pb-free

RoHS

#### PowerPAK ChipFET Single

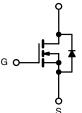




#### **APPLICATIONS**

 Load Switch, PA Switch, and Battery Switch for Portable Applications

DC-DC Synchronous Rectification



Ordering Information: Si5480DU-T1-GE3 (Lead (Pb)-free and Halogen-free)

N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b>	T <sub>A</sub> = 25 °C, unles	ss otherwise not	ed	
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V <sub>DS</sub>	30	V
Gate-Source Voltage		V <sub>GS</sub>	± 20	<b></b>
	T <sub>C</sub> = 25 °C		12 <sup>a</sup>	
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	l <sub>a</sub>	12 <sup>a</sup>	
Continuous Diam Current (1) = 130 C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	10.7 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		8.6 <sup>b, c</sup>	Α
Pulsed Drain Current		I <sub>DM</sub> 30	30	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	Is	12 <sup>a</sup>	
	T <sub>A</sub> = 25 °C	'S	2.6 <sup>b, c</sup>	
	T <sub>C</sub> = 25 °C		31	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	20	w
	T <sub>A</sub> = 25 °C	' D	3.1 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		2 <sup>b, c</sup>	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>			260	$\exists$

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 5 s	R <sub>thJA</sub>	34	40	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	3	4	C/VV	

#### Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. See Solder Profile (http://www.vishay.com/ppg?73257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 90 °C/W.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	-						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	30			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = 250 uA		33		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 6.2			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1		3	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	ns	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1		
		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μΑ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
	В	$V_{GS} = 10 \text{ V}, I_D = 7.2 \text{ A}$		0.013	0.016		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 6.1 \text{ A}$		0.018	0.022	Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 15 \text{ V}, I_D = 7.2 \text{ A}$		23		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			1230		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		210			
Reverse Transfer Capacitance	C <sub>rss</sub>			115			
Total Gate Charge	$Q_g$	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10.7 \text{ A}$		22.5	34	nC	
				11	17		
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10.7 \text{ A}$		4.4			
Gate-Drain Charge	$Q_{gd}$			3.7			
Gate Resistance	$R_g$	f = 1 MHz		5.9		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			100	150	ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 1.7 $\Omega$		140	210		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 8.6 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		35	55		
Fall Time	t <sub>f</sub>			15	25		
Turn-On Delay Time	t <sub>d(on)</sub>			10	15		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 1.7 $\Omega$		10	15		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong$ 8.6 A, $V_{GEN}$ = 10 V, $R_g$ = 1 $\Omega$		40	60		
Fall Time	t <sub>f</sub>			8	15		
<b>Drain-Source Body Diode Characteristi</b>	cs						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			12	Α	
Pulse Diode Forward Current	I <sub>SM</sub>				30		
Body Diode Voltage	$V_{SD}$	$I_S = 8.6 \text{ A}, V_{GS} = 0 \text{ V}$		0.85	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			20	40	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 8.6 A, dl/dt = 100 A/μs, T <sub>.l</sub> = 25 °C		15	30	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	1 <sub>F</sub> = 0.0 A, αι/αι = 100 A/μs, 1 <sub>J</sub> = 25 °C		13		nc	
Reverse Recovery Rise Time	t <sub>b</sub>	t <sub>b</sub>		7		ns	

- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

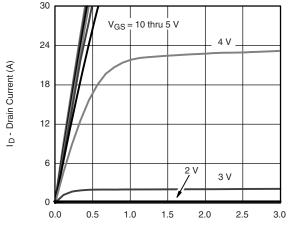


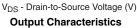


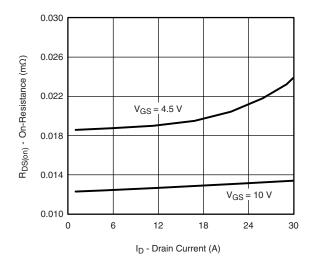
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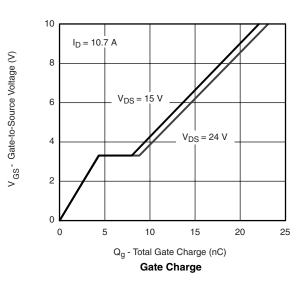
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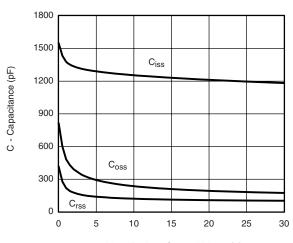


On-Resistance vs. Drain Current and Gate Voltage



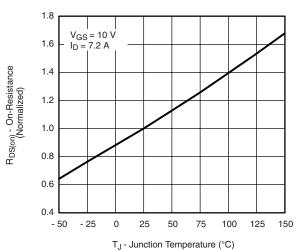
30 24 I<sub>D</sub> - Drain Current (A) 18 T<sub>C</sub> = 125 °C 12 6 T<sub>C</sub> = 25 °C - 55 °C 0 0 5

V<sub>GS</sub> - Gate-to-Source Voltage (V) **Transfer Characteristics** 



V<sub>DS</sub> - Drain-to-Source Voltage (V)

#### Capacitance



On-Resistance vs. Junction Temperature

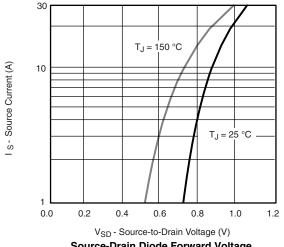
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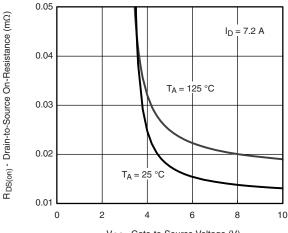
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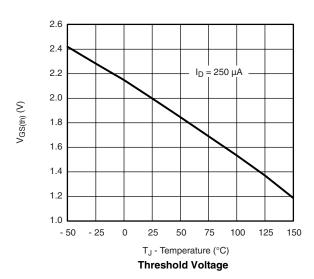
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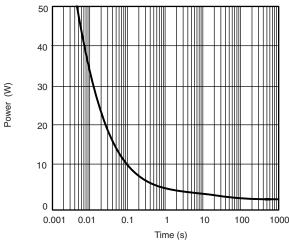




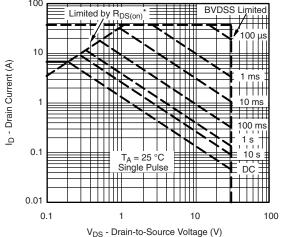
Source-Drain Diode Forward Voltage







Single Pulse Power, Junction-to-Ambient



\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area, Junction-to-Ambient

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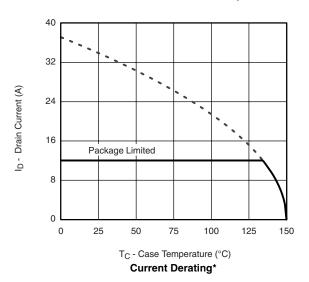
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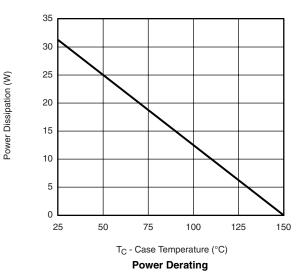


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 $<sup>^{\</sup>star}$  The power dissipation P<sub>D</sub> is based on T<sub>J(max)</sub> = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package

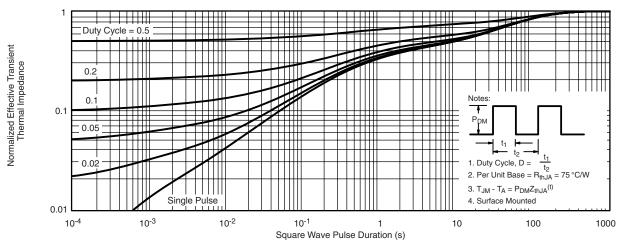
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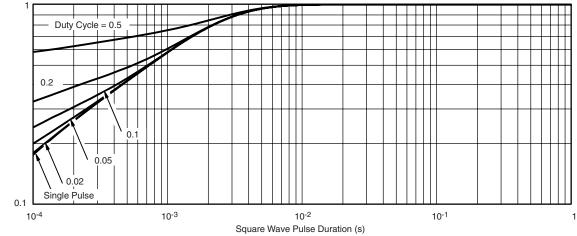
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#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="http://www.vishay.com/ppg?73585">http://www.vishay.com/ppg?73585</a>.

Normalized Effective Transient



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Revision: 13-Jun-16 1 Document Number: 91000